

[Go to Journal](#) [Return to Main Page](#) [Help/Feedback](#) [Log Out](#)

# AIP | Journal of Applied Physics

[About the Journal](#)[Preparing Your Manuscript](#)[Contact Editorial Office](#)[Visit JAP Online](#)[Check Production Status of Accepted Manuscripts](#)[Privacy Policy](#)

© 2017 AIP Publishing LLC  
1305 Walt Whitman Road, Suite 300, Melville, NY 11747-4300 USA



Is the reference list appropriate: Yes

Reviewer #1 (REMARKS to AUTHOR(s)):

The authors describe a technique to extract room temperature parameters of Schottky diodes when barrier height is voltage dependent. This problem (characterization of Schottky barriers) has been exhaustively studied for the last six decades and will continue due to the importance of this issue to devices developing.

The manuscript describes a (new?) method for current-voltage characteristics analysis based on the differential slope of the experimental I-V curves. Some references cited in the manuscript (Refs. 17-23) already give a route for a similar analysis: using the early text book models (Physics of Semiconductors Devices by S. M. Sze or the brilliant E. H. Rhoderick's Metal Semiconductor Contacts) and the differential slope of the experimental I-V curves one obtain the results presented here. In this sense, it appears to me that the paper does not present original results but instead only a different way (some parts already published, as cited in the manuscript) to extract out Schottky parameters.

Specific comments:

1. The authors claim that "The method was verified for MS, MSM and MIS structures with symmetric or asymmetric electrodes by measurement of the current voltage characteristics (I-V) at room temperature under different illumination regimes" but being a very studied subject why authors did not present a comparison with published or other "conventional" models?
2. From eq. (1) to eq. (2) there is a gap: eq. (1) describes only thermionic mechanism while eq. (2) present a combination of the thermionic and diffusion theory!  $J_{s1}$  or  $J_{s2}$  have not to account diffusion theory to be correct or to be used in eq. (1).
3. Authors wrote: "The Schottky barrier height is reduced in the dark due to both a variation of image force potential and a dipole layer, which results from an interfacial layer with surface trap states and or fixed charges at the MS boundary [1, 15, 16]. The barrier height reduces further under illumination [10]". The barrier reduces in dark conditions and reduces further under illumination. When does it increase?
4. Authors wrote: "...transmission coefficient of the barrier to be smaller than unity [15, 16]).....". Is that reasonable for the diodes studied here?
5. Experimental part:
  - 5a. A commercial Schottky diode was used: which one?
  - 5b. A figure of the devices built for this work should be presented.
6. When describing the results, authors wrote " The perfect coincidence testifies to the strength of the proposed method, which is simpler than the complicated current versus temperature technique of extraction, zero bias barrier height of single Schottky diodes [1]. " Why complicated? It has been used since 60's without problems!  
Also, the coincidence claimed by the authors is related to two equations described in the manuscript. Why there is not a comparison with published results?

7. Authors wrote: "The reason is that interfacial states would lead to an exponential dependence of the reverse saturation current on applied voltage and therefore a linear increase of  $\alpha$  with applied voltage, as predicted by equations (2) or (8) taking into consideration (3) and (4)." What distribution shape was authors using to describe the density of states? Constant density? Gaussian distribution? Please check Barret C. Thesis University of Paris-Sud, Orsay (1981); Barret C and Vapaille A, Solid State Electron. 18, 25 (1975).

7. It is claimed (page 10, first and second paragraphs from the bottom) that "ideality factor ...in the present case is 1.12... The small deviation of the ideality factor from a value of unity indicates that the current flow by thermionic emission is disturbed by the effect of the voltage dependent image force potential".

However  $n=1.12$  is too much for image force influence. In this case

$$n=1+0.25*(q^3 Nd / 8 \pi^2 (e_0 \epsilon_s V_{bi})^3)^{0.25}$$

One can calculate, that for  $n=1.12$  and silicon

$$Nd=1.1e27 (V_{bi})^3 1/m^3.$$

Therefore semiconductor is degenerate, or diffusion potential is too small, or ideality factor value is not determined by image force. The last version is most probable. It is important to report some details about this situation in the text.

8. On my humble opinion, while referring on equation from table it is better to use (number) than raw and column.

9. Figure 4 (e) shows the barrier height alteration under illumination. On the one hand, quasi-Fermi level position can be calculated by eqs.(4) and (7). On the another hand, quasi-Fermi level position depend on non-equilibrium carrier concentration, which is determined by illumination power. The comparison of results, which obtained by this different way, would be interesting.

10. Page 12, 3-rd paragraph from the top: "In the dark and at small illumination powers,  $\Delta\phi_0$  values were extracted by the equation of raw II, column IV in table 1 while at large illuminations, we used the equation of row I, column IV." Which is rigorous criterion for every equation using (or separation of small and large illuminations)?

11. Page 13, 1-st paragraph from the top: "(see inset in Fig. 2 (b))" must be replaced by "(see inset in Fig. 6 (b)) "

12. Figure 7 presents zero bias barrier height. At such condition  $V_r$  equals to zero. Therefore expressions in row I and row III are equivalent. Why are results obtained from reverse and forward branches different?

13. The word "raw" (pages 12, 15) must be replaced by "row".

#### Reviewer #3 Evaluations:

Does the manuscript present original and timely results that significantly advance the knowledge in applied physics: Yes

Does the manuscript report on convincing and rigorous data methods and analysis: Yes

Is the manuscript clearly written in correct English well organized and free from ambiguities: Yes

Is the title descriptive of the contents concise interesting and free of acronyms: Yes

Does the abstract adequately and clearly describe the contents (problem approach findings) of the paper: Yes

Are the figures in the manuscript necessary adequate well presented and clearly labeled: No

Is the reference list appropriate: Yes

#### Reviewer #3 (REMARKS to AUTHOR(s)):

The presented work is good and interesting. The method presented is nicely explained with technical details and comparisons. The figures size is too big. Suggest changing the format.

[Print Email](#)

Close Window